

IGLD60R070D1

600V CoolGaN™ enhancement-mode Power Transistor

Features

- Enhancement mode transistor Normally OFF switch
- Ultra fast switching
- No reverse-recovery charge
- Capable of reverse conduction
- Low gate charge, low output charge
- Superior commutation ruggedness
- Qualified for industrial applications according to JEDEC Standards (JESD47 and JESD22)

Benefits

- Improves system efficiency
- Improves power density
- Enables higher operating frequency
- System cost reduction savings
- Reduces EMI

Applications

Industrial, telecom, datacenter SMPS based on the half-bridge topology (half-bridge topologies for hard and soft switching such as Totem pole PFC, high frequency LLC).

For other applications: review CoolGaN[™] reliability white paper and contact Infineon regional support



Parameter	Value	Unit	
$V_{DS,max}$	600	V	
R _{DS(on),max}	70	mΩ	
$Q_{G,typ}$	5.8	nC	
I _{D,pulse}	60	А	
Q _{oss} @ 400 V	41	nC	
Qrr	0	nC	





Gate	8
Drain	1,2,3,4
Kelvin Source	7
Source	5,6

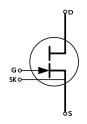








Table 2 Ordering Information

Type / Ordering Code	Package	Marking	Related links
IGLD60R070D1	PG-LSON-8-1	60R070D1	see Appendix A

Final Data Sheet

Downloaded from Arrow.com.

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1 Maximum ratings

at T_j = 25 °C, unless otherwise specified. Continuous application of maximum ratings can deteriorate transistor lifetime. For further information, contact your local Infineon sales office.

Table 3 Maximum ratings

Parameter	Symbol		Values		Unit	Note/Test Condition	
		Min.	Тур.	Max.			
Drain Source Voltage, continuous ¹	$V_{DS,max}$	-	-	600	V	V _{GS} = 0 V	
Drain source destructive breakdown voltage ²	V _{DS,bd}	800	-	-	V	$V_{GS} = 0 \text{ V}, I_{DS} = 12.2 \text{ mA}$	
Drain source voltage, pulsed ²	$V_{DS,pulse}$	-	-	750	V	$T_j = 25$ °C; $V_{GS} \le 0$ V; ≤ 1 hour of total time	
				650	V	$T_j = 125$ °C, $V_{GS} \le 0$ V; ≤ 1 hour of total time	
Switching surge voltage, pulsed ²	$V_{DS,surge}$	1	-	750	V	DC bus voltage = 700 V; turn off $V_{DS,pulse}$ = 750 V; turn on $I_{D,pulse}$ = 27 A; T_j = 105 °C; $f \le 100 \text{ kHz}$, $t \le 100 \text{ secs}$ (10 million pulses)	
Continuous current, drain source	I_D	-	-	15	Α	T _C = 25 °C;	
Pulsed current, drain source ³⁴	I _{D,pulse}	-	-	60	Α	$T_C = 25 ^{\circ}\text{C}; I_G = 26.1 \text{mA};$	
						See Figure 3;	
Pulsed current, drain source 45	$I_{D,pulse}$	-	-	35	А	T_c = 125 °C; I_G = 26.1 mA; See Figure 4;	
Gate current, continuous 456	$I_{G,avg}$	-	-	20	mA	$T_j = -55 ^{\circ}\text{C} \text{ to } 150 ^{\circ}\text{C};$	
Gate current, pulsed 46	I _{G,pulse}	-	-	2000	mA	$T_j = -55 ^{\circ}\text{C}$ to 150 $^{\circ}\text{C}$; $t_{\text{PULSE}} = 50 \text{ns}, f = 100 \text{kHz}$	
Gate source voltage, continuous ⁶	V_{GS}	-10	-	-	V	$T_j = -55 ^{\circ}\text{C} \text{ to } 150 ^{\circ}\text{C};$	
Gate source voltage, pulsed ⁶	V _{GS,pulse}	-25	-	-	V	T_j = -55 °C to 150 °C; t_{PULSE} = 50 ns, f = 100 kHz; open drain	
Power dissipation	P _{tot}	-	-	114	W	T _c = 25 °C	
Operating temperature	Tj	-55	-	150	°C		
Storage temperature	T _{stg}	-55	-	150	°C	Max shelf life depends on storage conditions.	
Drain-source voltage slew-rate	dV/dt			200	V/ns		

¹ All devices are 100% tested at I_{DS} = 12.2 mA to assure $V_{DS} \ge 800 \text{ V}$

² Provided as measure of robustness under abnormal operating conditions and not recommended for normal operation

³ Limits derived from product characterization, parameter not measured during production

⁴ Ensure that average gate drive current, I_{G,avg} is ≤ 20 mA. Please see figure 27 for I_{G,avg}, I_{G,pulse} and I_G details

⁵ Parameter is influenced by rel-requirements. Please contact the local Infineon Sales Office to get an assessment of your application

⁶ We recommend using an advanced driving technique to optimize the device performance. Please see gate drive application note for details

2 Thermal characteristics

Table 4 Thermal characteristics

Parameter	Symbol	Symbol Values		Unit	Note/Test Condition	
		Min.	Тур.	Max.		
Thermal resistance, junction-case	R_{thJC}	-	-	1.1	°C/W	
Reflow soldering temperature	T_{sold}	-	-	260	°C	MSL3

3 Electrical characteristics

at T_i = 25 °C, unless specified otherwise

Table 5 Static characteristics

Parameter	Symbol		Values		Values		Unit	Note/Test Condition
		Min.	Тур.	Мах.				
Gate threshold voltage	$V_{GS(th)}$	0.9	1.2	1.6	V	I_{DS} = 2.6 mA; V_{DS} = 10 V; T_j = 25 °C		
		0.7	1.0	1.4		I_{DS} = 2.6 mA; V_{DS} = 10 V; T_j =125 °C		
Gate-Source reverse clamping voltage	$V_{\text{GS, clamp}}$	-		-8	V	I _{GSS} = -1 mA		
Drain-Source leakage current		-	1	100	μΑ	$V_{DS} = 600 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$		
	I _{DSS}	-	20	-		$V_{DS} = 600 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 \text{ °C}$		
Drain-Source leakage current at application conditions ¹	I _{DSSapp}	-	60	-	μΑ	$V_{DS} = 400 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 125 \text{ °C}$		
Drain-Source on-state resistance		-	0.055	0.070	Ω	$I_G = 26.1 \text{ mA}; I_D = 8 \text{ A}; T_j = 25 ^{\circ}\text{C}$		
	$R_{DS(on)}$	-	0.100	1		$I_G = 26.1 \text{ mA}; I_D = 8 \text{ A}; T_j = 150 \text{ °C}$		
Gate resistance	$R_{G,int}$	-	0.78	-	Ω	LCR impedance measurement; f = f _{res} ; open drain;		

Table 6 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note/Test Condition
		Min.	Тур.	Max.		
Input capacitance	C _{iss}	-	380	-	pF	V _{GS} = 0 V; V _{DS} = 400 V; f = 1 MHz
Output capacitance	C _{oss}	-	72	-	pF	$V_{GS} = 0 \text{ V}; V_{DS} = 400 \text{ V};$ f = 1 MHz
Reverse Transfer capacitance	C _{rss}	-	0.3	-	pF	$V_{GS} = 0 \text{ V}; V_{DS} = 400 \text{ V};$ f = 1 MHz
Effective output capacitance, energy related ²	C _{o(er)}	-	80	-	pF	V _{DS} = 0 to 400 V
Effective output capacitance, time related ³	C _{o(tr)}	-	102.5	-	pF	$V_{GS} = 0 \text{ V}; V_{DS} = 0 \text{ to } 400 \text{ V};$ Id = const
Output charge	Qoss	-	41	-	nC	V _{DS} = 0 to 400 V
Turn- on delay time	t _{d(on)}	-	10	-	ns	see Figure 23
Turn- off delay time	t _{d(off)}	-	14	-	ns	see Figure 23
Rise time	t _r	-	8	-	ns	see Figure 23
Fall time	t _f	-	15	-	ns	see Figure 23

 $^{^{\}rm 1}\,\mbox{Parameter}$ represents end of use leakage in applications

 $^{^{2}}$ C_{o(er)} is a fixed capacitance that gives the same stored energy as Coss while VDS is rising from 0 to 400 V

 $^{^3}$ C $_{\!o(tr)}$ is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 to 400 V

Table 7 Gate charge characteristics

Parameter	Symbol	Values		Values		Note/Test Condition
		Min.	Тур.	Max.		
Gate charge	Q _G	-	5.8	-	nC	I _{GS} = 0 to 10 mA; V _{DS} = 400 V; I _D = 8 A

Table 8 Reverse conduction characteristics

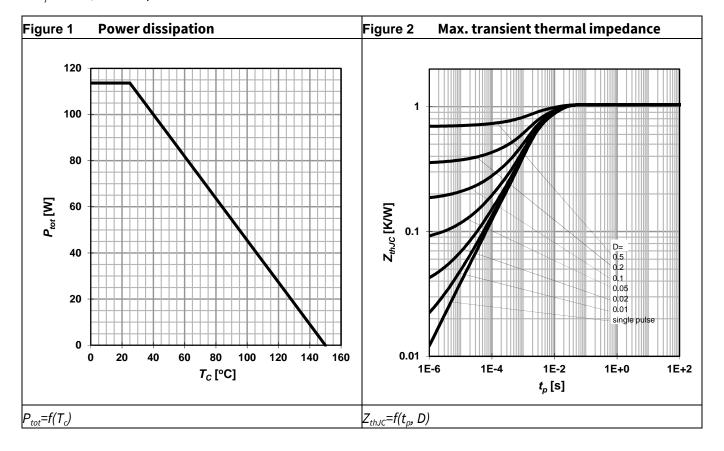
Parameter	Symbol	Values		Unit	Note/Test Condition	
		Min.	Тур.	Max.		
Source-Drain reverse voltage	V_{SD}	-	2.2	2.5	V	$V_{GS} = 0 \text{ V; } I_{SD} = 8 \text{ A}$
Pulsed current, reverse	I _{S,pulse}	-	-	60	Α	I _G = 26.1 mA
Reverse recovery charge	Q _{rr} ¹	-	0	-	nC	$I_S = 8 \text{ A}, V_{DS} = 400 \text{ V}$
Reverse recovery time	t _{rr}	-	0	-	ns	
Peak reverse recovery current	I _{rrm}	-	0	-	Α	

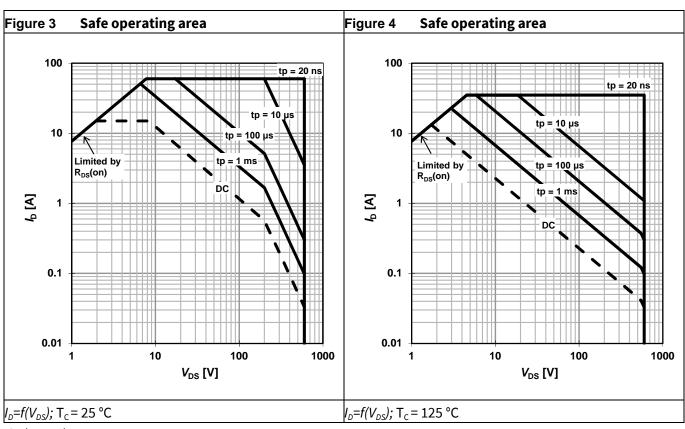
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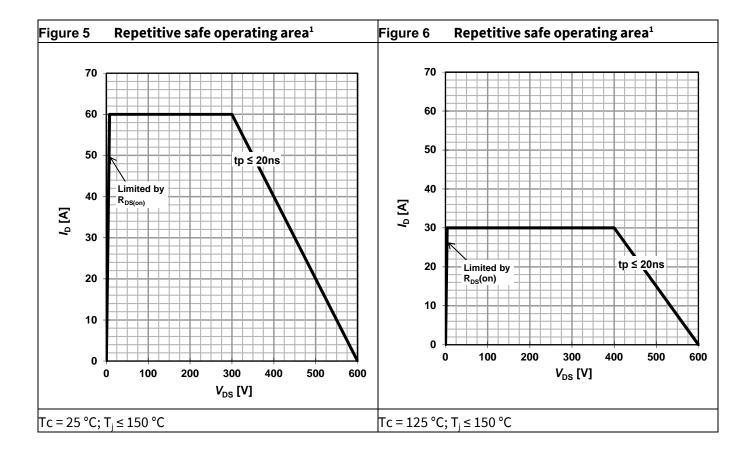
¹ Excluding Qoss Final Data Sheet

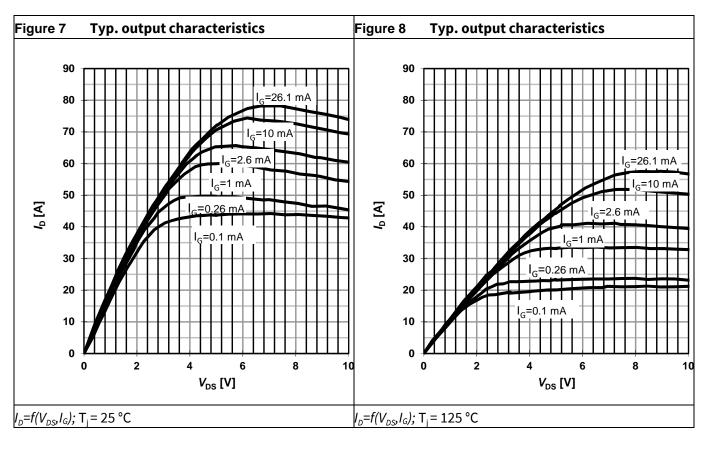
4 Electrical characteristics diagrams

at T_i = 25 °C, unless specified otherwise



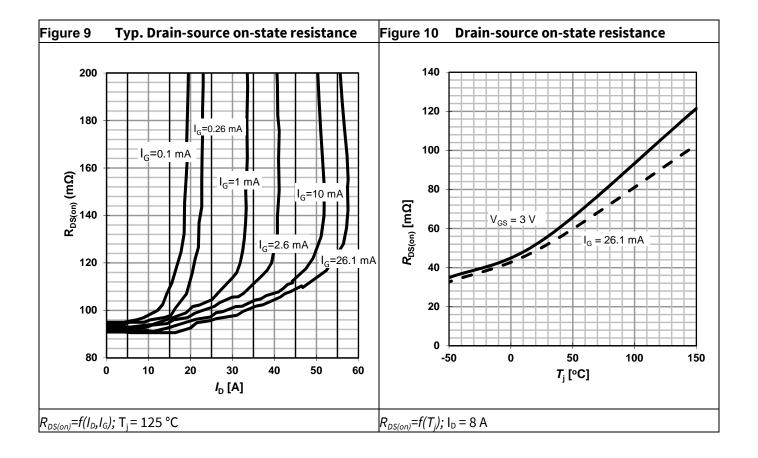


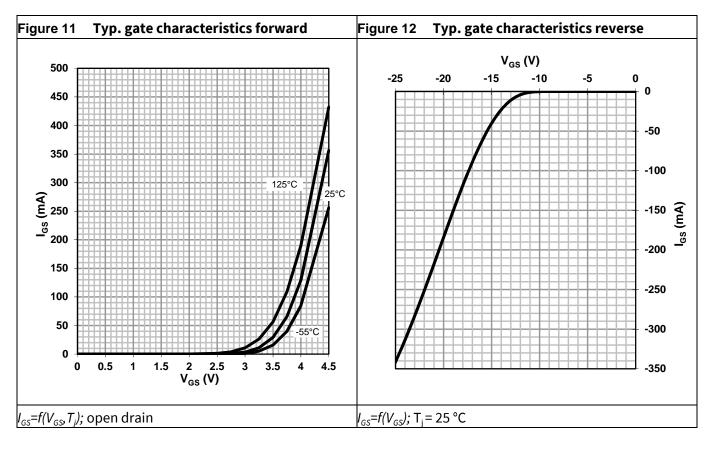


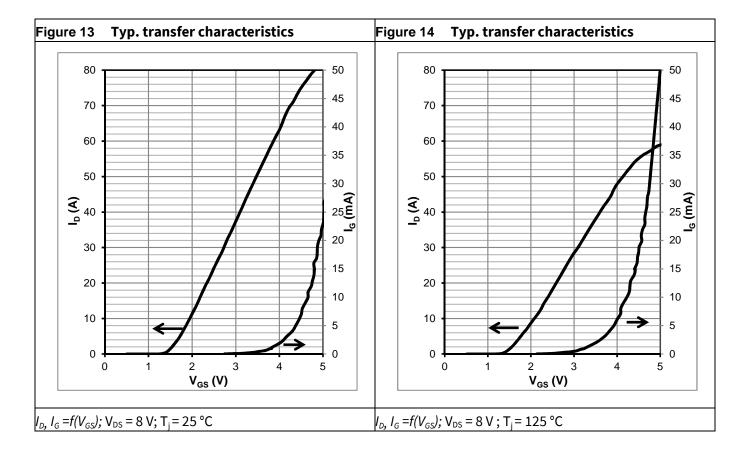


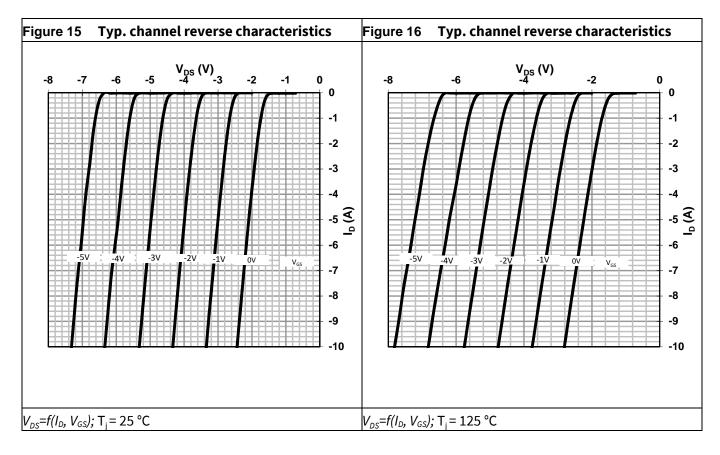
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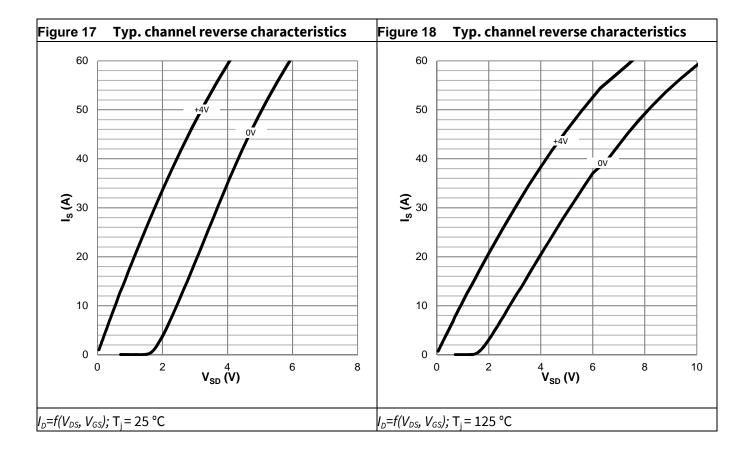
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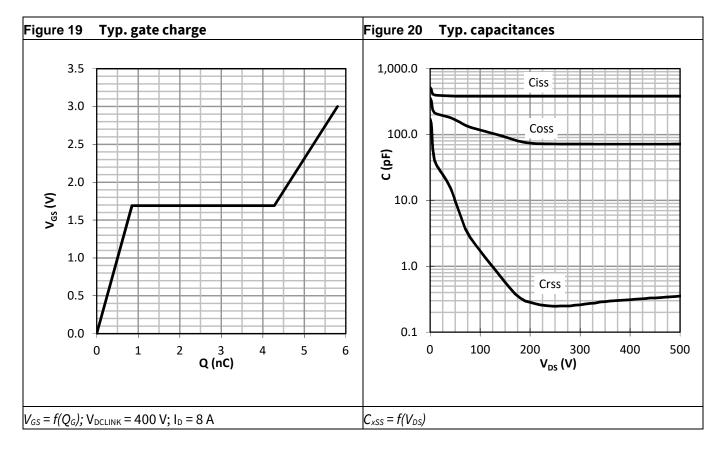


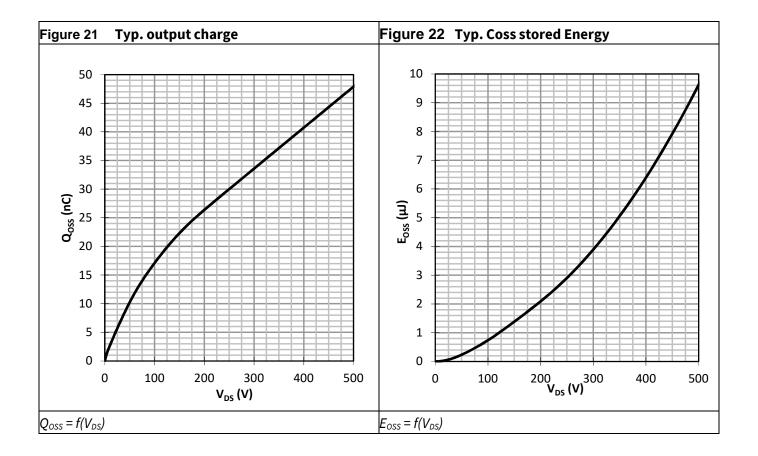




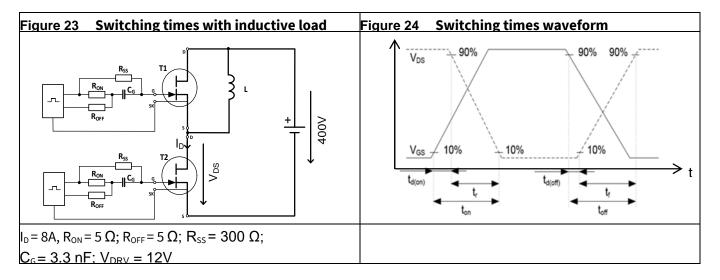


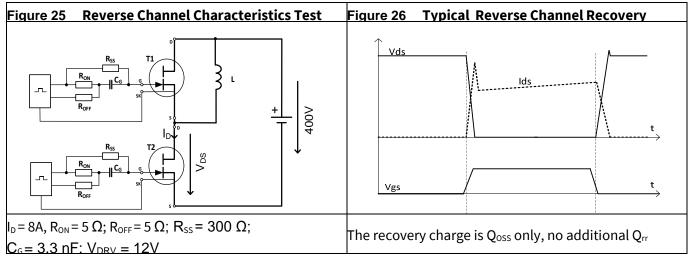


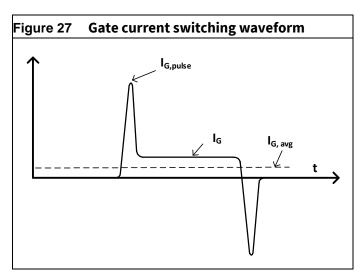




5 Test Circuits







6 Package Outlines

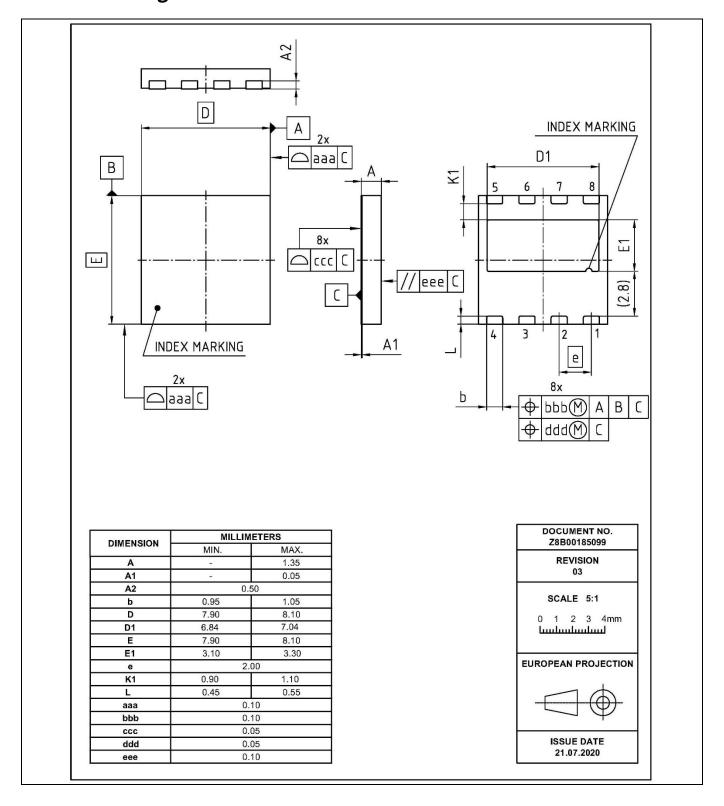


Figure 28 PG-LSON-8-1 Package Outline, dimensions (mm)

7 Appendix A

Table 9 Related links

- IFX CoolGaN™ webpage: www.infineon.com/why-coolgan
- IFX CoolGaN™ reliability white paper: <u>www.infineon.com/gan-reliability</u>
- IFX CoolGaN™ gate drive application note: <u>www.infineon.com/driving-coolgan</u>
- IFX CoolGaN[™] applications information:
 - o www.infineon.com/gan-in-server-telecom
 - o www.infineon.com/gan-in-wirelesscharging
 - o www.infineon.com/gan-in-audio
 - o <u>www.infineon.com/gan-in-adapter-charger</u>

8 Revision History

Major changes since the last revision

Revision	Date	Description of changes
2.0	2018-10-12	Final version release
2.1	2020-01-16	Added V _{DS,bd} , V _{DS,pulse} , V _{DS,surge} specifications in maximum ratings table of page3
2.11	2020-08-07	Updated package tolerances in Figure 28
2.12	2021-04-27	Updated T_{sold} specification to 260°C in table 4; Updated I_{GSS} specification at 125°C to -2 mA in table 5; updated repetitive SOA at T_c = 125°C to 30A in Figure 6; updated switching times and related test conditions
2.13	2021-10-26	Replaced I _{GSS} specification with V _{GS, clamp} in table 5

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